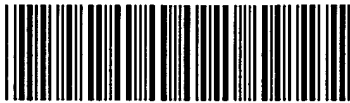


Search Notes

Application/Control No.

10/669,347

Examiner

Sang Nguyen

Applicant(s)/Patent under
Reexamination

NAKANO, TAKAHIKO

Art Unit

2877

SEARCHED

| Class | Subclass | Date | Examiner |
|-------|----------|-----------|----------|
| 356 | 601-624 | 9/25/2006 | SN |
| ↕ | 4.04 | ↑ | ↑ |
| 250 | 559.23 | | |
| ↑ | 559.38 | | |
| | 559.06 | | |
| | 559.07 | | |
| | 201.2 | | |
| | 201.6 | | |
| | 205 | | |
| | 208.1 | ↓ | ↓ |
| ↓ | 208.2 | 9/25/2006 | SN |
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INTERFERENCE SEARCHED

| Class | Subclass | Date | Examiner |
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| Same as | above | 9/25/2006 | SN |
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**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

| | DATE | EXMR |
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| EAST- see Searched History Printout | 9/25/2006 | SN |
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